ALPHA & OMEGA SEMICONDUCTOR 500V, 5A N-Channel MOSFET with Fast Recovery Diode										
General Description			Product Summary							
The AOTF5N50FD has been fabricated using an advanced high voltage MOSFET process that is designed to deliver high levels of performance and robustness in popular AC-DC applications. By providing low $R_{DS(on)}$, C_{iss} and C_{rss} along with guaranteed avalanche capability this part can be adopted quickly into new and existing offline power supply designs.			V_{DS} I _D (at V _{GS} =10V) R _{DS(ON)} (at V _{GS} =10V)	600V@150℃ 5A <1.8Ω						
			100% UIS Tested 100% R _g Tested	Green						
	op View O-220F		G							
	G G			o s						
	rF5N50FD G Ratings T _A =25°C unles									
Parameter	Ratings $T_A = 25^{\circ}C$ unles	Symbol	AOTF5N50FD	Units						
Parameter Drain-Source Voltage	Ratings $T_A = 25^{\circ}C$ unles	Symbol V _{DS}	AOTF5N50FD 500	Units V						
Parameter Drain-Source Voltage Gate-Source Voltage	Ratings T _A =25°C unles	Symbol	AOTF5N50FD 500 ±30	Units						
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain	Ratings $T_A=25^{\circ}C$ unles $T_C=25^{\circ}C$	Symbol V _{DS}	AOTF5N50FD 500 ±30 5*	Units V V						
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current	Ratings $T_A=25^{\circ}C$ unles $T_C=25^{\circ}C$ $T_C=100^{\circ}C$	Symbol V _{DS} V _{GS}	AOTF5N50FD 500 ±30 5* 3*	Units V						
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current Pulsed Drain Current	Ratings $T_A=25^{\circ}C$ unles $T_C=25^{\circ}C$ $T_C=100^{\circ}C$	Symbol V _{DS} V _{GS} I _D I _{DM}	AOTF5N50FD 500 ±30 5* 3* 13	Units V V A A						
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current Pulsed Drain Current Avalanche Current ^C	Ratings $T_A=25^{\circ}C$ unles $T_C=25^{\circ}C$ $T_C=100^{\circ}C$	Symbol V _{DS} V _{GS} I _D I _{DM} I _{AR}	AOTF5N50FD 500 ±30 5* 3* 13 2.3	Units V V A A						
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current Pulsed Drain Current Avalanche Current ^C Repetitive avalanche	Ratings $T_A=25^{\circ}C$ unles $T_C=25^{\circ}C$ $T_C=100^{\circ}C$ energy C	Symbol V _{DS} V _{GS} I _D I _{DM} I _{AR} E _{AR}	AOTF5N50FD 500 ±30 5* 3* 13 2.3 79	Units V V A A mJ						
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current Pulsed Drain Current Avalanche Current ^C Repetitive avalanche Single pulsed avalance	Ratings $T_A=25^{\circ}C$ unles $T_C=25^{\circ}C$ $T_C=100^{\circ}C$ c energy ^C c c c c c c c c c c c c c c c c c c c	Symbol V _{DS} V _{GS} 	AOTF5N50FD 500 ±30 5* 3* 13 2.3 79 158	Units V V V A A A MJ MJ						
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current Pulsed Drain Current Avalanche Current ^C Repetitive avalanche	Ratings $T_A=25^{\circ}C$ unles $T_C=25^{\circ}C$ $T_C=100^{\circ}C$ c energy ^C che energy ^G dv/dt	Symbol V _{DS} V _{GS} I _D I _{DM} I _{AR} E _{AR}	AOTF5N50FD 500 ±30 5* 3* 13 2.3 79 158 5	Units V V A A MJ V/ns						
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current Pulsed Drain Current Avalanche Current ^C Repetitive avalanche Single pulsed avalance Peak diode recovery of	Ratings $T_A=25^{\circ}C$ unles $T_C=25^{\circ}C$ $T_C=100^{\circ}C$ c energy ^C che energy ^G dv/dt $T_C=25^{\circ}C$	Symbol V _{DS} V _{GS} 	AOTF5N50FD 500 ±30 5* 3* 13 2.3 79 158 5 35	Units V V A A A M A M J M J V/ns W						
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current Pulsed Drain Current Avalanche Current ^C Repetitive avalanche Single pulsed avalance Peak diode recovery of Power Dissipation ^B	Ratings $T_A=25^{\circ}C$ unles $T_C=25^{\circ}C$ $T_C=100^{\circ}C$ c energy C che energy C ch	$\begin{tabular}{ c c c c } \hline Symbol & V_{DS} & V_{GS} & V_{GS} & \\ \hline & I_D & & I_{DM} & \\ & I_{AR} & & E_{AR} & \\ & E_{AR} & & E_{AS} & \\ & & dv/dt & & \\ \hline & & P_D & & \\ \hline \end{tabular}$	AOTF5N50FD 500 ±30 5* 3* 13 2.3 79 158 5 35 0.3	Units V V A A MJ V/ns W W/ °C						
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current Pulsed Drain Current Avalanche Current ^C Repetitive avalanche Single pulsed avalance Peak diode recovery of Power Dissipation ^B Junction and Storage	Ratings $T_A=25^{\circ}C$ unles $T_C=25^{\circ}C$ $T_C=100^{\circ}C$ c energy C che energy C dv/dt $T_C=25^{\circ}C$ Derate above $25^{\circ}C$ Temperature Range	Symbol V_{DS} V_{GS} I_D I_{DM} I_{AR} E_{AR} E_{AS} dv/dt	AOTF5N50FD 500 ±30 5* 3* 13 2.3 79 158 5 35	Units V V A A A M A M J M J V/ns W						
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current Pulsed Drain Current Avalanche Current ^C Repetitive avalanche Single pulsed avalance Peak diode recovery of Power Dissipation ^B Junction and Storage Maximum lead tempe purpose, 1/8" from ca	Ratings $T_A=25^{\circ}C$ unles $T_C=25^{\circ}C$ $T_C=100^{\circ}C$ c energy C che energy G dv/dt $T_C=25^{\circ}C$ Derate above $25^{\circ}C$ Temperature Range rature for soldering se for 5 seconds	$\begin{tabular}{ c c c c } \hline Symbol & V_{DS} & V_{GS} & V_{GS} & \\ \hline & I_D & & I_{DM} & \\ & I_{AR} & & E_{AR} & \\ & E_{AR} & & E_{AS} & \\ & & dv/dt & & \\ \hline & & P_D & & \\ \hline \end{tabular}$	AOTF5N50FD 500 ±30 5* 3* 13 2.3 79 158 5 35 0.3	Units V V A A MJ V/ns W W/ °C						
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current Pulsed Drain Current Avalanche Current ^C Repetitive avalanche Single pulsed avalance Peak diode recovery of Power Dissipation ^B Junction and Storage Maximum lead tempe purpose, 1/8" from car Thermal Characteris	Treatings $T_A=25^\circ$ C unles T_c=25^\circC T_c=100^\circC C C energy C che energy G dv/dt T_c=25^\circC Derate above 25^\circC Temperature Range rature for soldering se for 5 seconds stics Seconds	Symbol V _{DS} V _{GS} I _D I _{DM} I _{AR} E _{AR} E _{AS} dv/dt P _D T _J , T _{STG} T _L	AOTF5N50FD 500 ±30 5* 3* 13 2.3 79 158 5 35 0.3 -55 to 150 300	Units ∨ ∨ ∧ A A MJ W/ns W/°C °C						
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current Pulsed Drain Current Avalanche Current ^C Repetitive avalanche Single pulsed avalance Peak diode recovery of Power Dissipation ^B Junction and Storage Maximum lead tempe purpose, 1/8" from car Thermal Characteris	Ratings $T_A=25^{\circ}C$ unles $T_C=25^{\circ}C$ $T_C=100^{\circ}C$ c energy C che energy G dv/dt $T_C=25^{\circ}C$ Derate above $25^{\circ}C$ Temperature Range rature for soldering se for 5 seconds ttics rameter	Symbol V _{DS} V _{GS} I _D I _{DM} I _{AR} E _{AR} E _{AS} dv/dt P _D T _J , T _{STG} T _L Symbol	AOTF5N50FD 500 ±30 5* 3* 13 2.3 79 158 5 35 0.3 -55 to 150 300 AOTF5N50FD	Units V V A A MJ W/ns W/nc °C Units						
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current Pulsed Drain Current Avalanche Current ^C Repetitive avalanche Single pulsed avalance Peak diode recovery of Power Dissipation ^B Junction and Storage Maximum lead tempe purpose, 1/8" from car Thermal Characteris	Treatings T_a=25°C unles T_c=25°C T_c=100°C T_c=100°C C c C energy C c C dv/dt T_c=25°C T_c=25°C Derate above 25°C Temperature Range rature for soldering se for 5 seconds Stics rameter -Ambient ^{A,D}	Symbol V _{DS} V _{GS} I _D I _{DM} I _{AR} E _{AR} E _{AS} dv/dt P _D T _J , T _{STG} T _L	AOTF5N50FD 500 ±30 5* 3* 13 2.3 79 158 5 35 0.3 -55 to 150 300	Units ∨ ∨ ∧ A A MJ W/ns W/°C °C						

* Drain current limited by maximum junction temperature.



Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
STATIC	PARAMETERS					
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =10mA, V _{GS} =0V, T _J =25°C	500			
		I_{D} =10mA, V_{GS} =0V, T_{J} =150°C		600		V
BV _{DSS} /∆TJ	Breakdown Voltage Temperature Coefficient	I _D =10mA, V _{GS} =0V		0.56		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =500V, V _{GS} =0V			10	μA
		V _{DS} =400V, T _J =125°C			100	
I _{GSS}	Gate-Body leakage current	$V_{DS}=0V, V_{GS}=\pm 30V$			±100	nA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =5V, I _D =250μA	2.5	3.5	4.2	V
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =2.5A		1.5	1.8	Ω
g _{FS}	Forward Transconductance	V _{DS} =40V, I _D =2.5A		4		S
V_{SD}	Diode Forward Voltage	I _S =5A,V _{GS} =0V		0.93	1.6	V
I _s	Maximum Body-Diode Continuous Current				5	А
I _{SM}	Maximum Body-Diode Pulsed Current				13	А
DYNAMI	C PARAMETERS					
C _{iss}	Input Capacitance		350	440	530	pF
C _{oss}	Output Capacitance	V _{GS} =0V, V _{DS} =25V, f=1MHz	35	50	65	pF
C _{rss}	Reverse Transfer Capacitance		2.5	4.5	6.5	pF
R _g	Gate resistance	V_{GS} =0V, V_{DS} =0V, f=1MHz	1.7	3.4	5.2	Ω
SWITCH	ING PARAMETERS					
Q _g	Total Gate Charge	V _{GS} =10V, V _{DS} =400V, I _D =5A	8	11	15	nC
Q_{gs}	Gate Source Charge			2.7		nC
Q_{gd}	Gate Drain Charge			3.8		nC
t _{D(on)}	Turn-On DelayTime			18		ns
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =250V, I_{D} =5A,		33		ns
t _{D(off)}	Turn-Off DelayTime	$R_{G}=25\Omega$		31		ns
t _f	Turn-Off Fall Time			26		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =5A,dI/dt=100A/μs,V _{DS} =100V		87	145	ns
Q _{rr}	Body Diode Reverse Recovery Charge	e I _F =5A,dl/dt=100A/μs,V _{DS} =100V		0.2	0.4	μC

A. The value of R $_{\rm 0JA}$ is measured with the device in a still air environment with T $_{\rm A}$ =25 $^{\circ}$ C.

B. The power dissipation P_D is based on $T_{J(MAX)}$ =150° C, using junction-to-case thermal resistance, and is more useful in setting the upper

dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}=150^{\circ}$ C, Ratings are based on low frequency and duty cycles to keep initial $T_{J}=25^{\circ}$ C.

D. The R $_{\rm 0JA}$ is the sum of the thermal impedance from junction to case R $_{\rm 0JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 μ s pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsin k, assuming a maximum junction temperature of $T_{J(MAX)}$ =150° C. The SOA curve provides a single pulse rating.

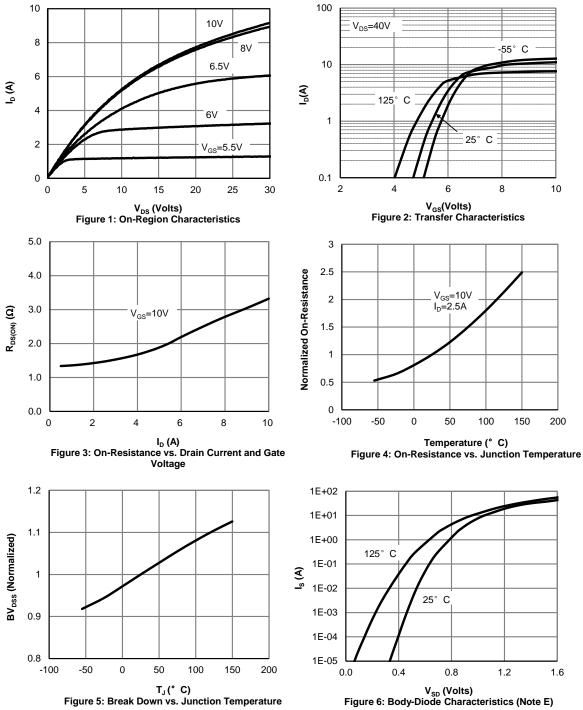
G. L=60mH, I_{AS}=2.3A, V_{DD}=150V, $R_G=25\Omega$, Starting T_J=25° C

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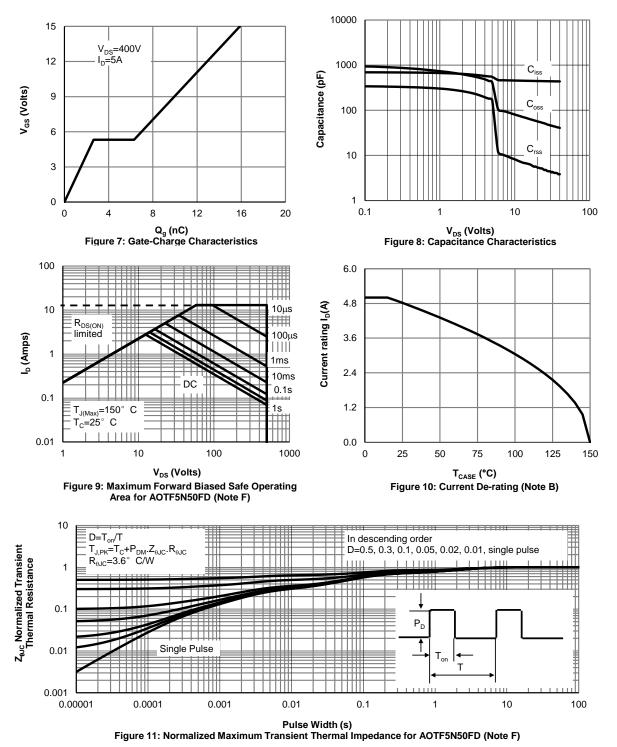


TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





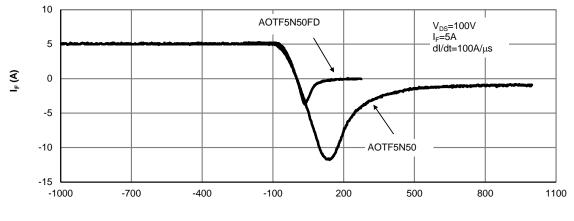
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS







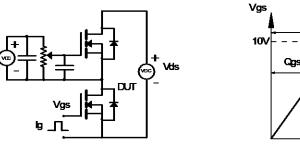
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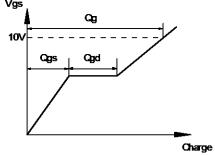


Trr (nS) Figure 12: Diode Recovery Characteristics

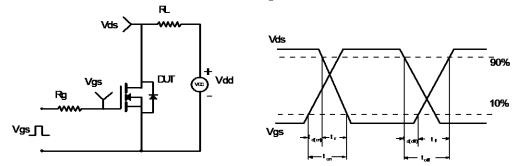


Gate Charge Test Circuit & Wave form

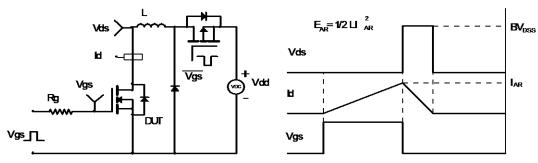




Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

